

**Search Notes**

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Khanh V. Nguyen

Applicant(s)/Patent under  
Reexamination

CHU, PETER F.

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
See Search History Printout		10/12/2005	NKV

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	10/12/2005	NKV